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Aerospace and Electronic Systems Magazine, IEEE , Volume: 19 , Issue: 8 , A 2004

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2 Fingerprinting for security

Adhami, R.; Meenen, P.;

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3 Parasitic authentication to protect your e-wallet

Ebringer, T.; Thorne, P.; Zheng, Y.;

Computer , Volume: 33 , Issue: 10 , Oct. 2000

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4 Novel approach to automated fingerprint recognition

Wahab, A.; Chin, S.H.; Tan, E.C.;

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Vieira, M.; Fernandes, M.; Fantoni, A.; Louro, P.;

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Kyong Seok Paik; Chin Hyan Chung; Jin Ok Kim; Dae Jun Hwang;

Image Processing, 2001. Proceedings. 2001 International Conference on , Vol 3 , 7-10 Oct. 2001

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